

CY7C1024DV33

3-Mbit (128K X 24) Static RAM

Features

- High speed □ t_{AA} = 10 ns
- Low active power □ I_{CC} = 175 mA at 10 ns
- Low CMOS standby power □ I_{SB2} = 25 mA
- Operating voltages of 3.3 ± 0.3V
- 2.0V data retention
- Automatic power down when deselected
- TTL compatible inputs and outputs
- Easy memory expansion with CE₁, CE₂, and CE₃ features
- Available in Pb-free standard 119-ball PBGA

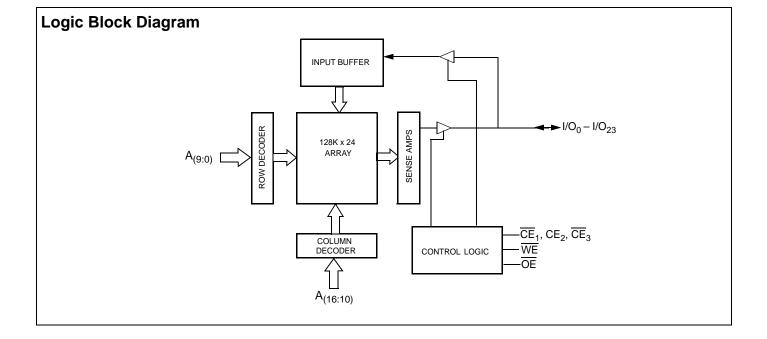
Functional Description

The CY7C1024DV33 is a high performance CMOS static RAM organized as 128K words by 24 bits. This device has an automatic power down feature that significantly reduces power consumption when deselected.

To write to the device, enable the chip ($\overline{CE}_1 LOW$, $CE_2 HIGH$, and $\overline{CE}_3 LOW$), while forcing the Write Enable (WE) input LOW.

To read from the device, enable the chip by taking $\overline{CE}_1 \underline{LOW}$, $CE_2 \underline{HIGH}$, and $\overline{CE}_3 \underline{LOW}$ while forcing the Output Enable (\overline{OE}) \underline{LOW} and the Write Enable (\overline{WE}) HIGH. See the Truth Table on page 7 for a complete description of Read and Write modes.

The 24 I/O pins (I/O₀ to I/O₂₃) are placed in a high impedance state when the device is deselected (CE₁ HIGH, CE₂ LOW, or CE₃ HIGH) or when the output enable (OE) is HIGH during a write operation. (CE₁ LOW, CE₂ HIGH, CE₃ LOW, and WE LOW).



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Selection Guide

Description	–10	Unit
Maximum Access Time	10	ns
Maximum Operating Current	175	mA
Maximum CMOS Standby Current	25	mA

Pin Configuration

	1	2	3	4	5	6	7
Α	NC	А	А	A	A	А	NC
В	NC	А	А	CE ₁	A	А	NC
С	I/O ₁₂	NC	CE ₂	NC	CE ₃	NC	I/O ₀
D	I/O ₁₃	V _{DD}	V _{SS}	V _{SS}	V _{SS}	V _{DD}	I/O ₁
E	I/O ₁₄	V _{SS}	V _{DD}	V _{SS}	V _{DD}	V _{SS}	I/O ₂
F	I/O ₁₅	V _{DD}	V _{SS}	V _{SS}	V _{SS}	V _{DD}	I/O ₃
G	I/O ₁₆	V _{SS}	V _{DD}	V _{SS}	V _{DD}	V _{SS}	I/O ₄
Н	I/O ₁₇	V _{DD}	V _{SS}	V _{SS}	V _{SS}	V _{DD}	I/O ₅
J	NC	V _{SS}	V _{DD}	V _{SS}	V _{DD}	V _{SS}	NC
К	I/O ₁₈	V _{DD}	V _{SS}	V _{SS}	V _{SS}	V _{DD}	I/O ₆
L	I/O ₁₉	V _{SS}	V _{DD}	V _{SS}	V _{DD}	V _{SS}	I/O ₇
М	I/O ₂₀	V _{DD}	V _{SS}	V _{SS}	V _{SS}	V _{DD}	I/O ₈
N	I/O ₂₁	V _{SS}	V _{DD}	V _{SS}	V _{DD}	V _{SS}	I/O ₉
Р	I/O ₂₂	V _{DD}	V _{SS}	V _{SS}	V _{SS}	V _{DD}	I/O ₁₀
R	I/O ₂₃	NC	NC	NC	NC	NC	I/O ₁₁
т	NC	А	А	WE	A	А	NC
U	NC	А	А	OE	A	А	NC

Figure 1. 119-Ball PBGA Top View ^[1]

Note
1. NC pins are not connected on the die.

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Maximum Ratings

Exceeding maximum ratings may impair the useful life of the device. These user guidelines are not tested.

Storage Temperature65°C to +150°C	
Ambient Temperature with Power Applied55°C to +125°C	
Supply Voltage on V_{CC} Relative to GND $^{[2]}\!0.5V$ to +4.6V	
DC Voltage Applied to Outputs in High Z State $^{[2]}\mbox{.}$ –0.5V to V $_{CC}$ + 0.5V	

DC Input Voltage ^[2]	–0.5V to V_{CC} + 0.5V
Current into Outputs (LOW)	20 mA
Static Discharge Voltage	>2001V
(MIL-STD-883, Method 3015)	
Latch Up Current	>200 mA

Operating Range

Range	Ambient Temperature	V _{cc}
Industrial	–40°C to +85°C	$3.3V\pm0.3V$

DC Electrical Characteristics

Over the Operating Range

Parameter	Description	Test Conditions ^[3]	_	Unit	
Parameter	Description	Test Conditions (*)	Min	Max	Unit
V _{OH}	Output HIGH Voltage	$V_{CC} = Min, I_{OH} = -4.0 \text{ mA}$	2.4		V
V _{OL}	Output LOW Voltage	$V_{CC} = Min, I_{OL} = 8.0 mA$		0.4	V
V _{IH}	Input HIGH Voltage		2.0	V _{CC} + 0.3	V
V _{IL} [2]	Input LOW Voltage		-0.3	0.8	V
I _{IX}	Input Leakage Current	$GND \leq V_I \leq V_{CC}$	-1	+1	μΑ
I _{OZ}	Output Leakage Current	$GND \leq V_{OUT} \leq V_{CC}$, output disabled	-1	+1	μΑ
I _{CC}	V _{CC} Operating Supply Current	V _{CC} = Max, f = f _{MAX} = 1/t _{RC} I _{OUT} = 0 mA CMOS levels		175	mA
I _{SB1}	Automatic CE Power Down Current —TTL Inputs	$\begin{array}{l} \text{Max } V_{CC}, \overline{CE} \geq V_{IH} \\ V_{IN} \geq V_{IH} \text{ or } V_{IN} \leq V_{IL}, f = f_{MAX} \end{array}$		30	mA
I _{SB2}	Automatic CE Power Down Current — CMOS Inputs	$\begin{array}{l} \text{Max } V_{\text{CC}}, \ \overline{\text{CE}} \geq V_{\text{CC}} - 0.3\text{V}, \\ V_{\text{IN}} \geq V_{\text{CC}} - 0.3\text{V}, \ \text{or} \ V_{\text{IN}} \leq 0.3\text{V}, \ \text{f} = 0 \end{array}$		25	mA

Capacitance

Tested initially and after any design or process changes that may affect these parameters.

Parameter	Description	Test Conditions	Max	Unit
C _{IN}	Input Capacitance	T _A = 25°C, f = 1 MHz, V _{CC} = 3.3V	8	pF
C _{OUT}	I/O Capacitance		10	pF

Thermal Resistance

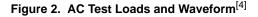
Tested initially and after any design or process changes that may affect these parameters.

Parameter	Description	Test Conditions	119-Ball PBGA	Unit
Θ_{JA}	Thermal Resistance (Junction to Ambient)	Still air, soldered on a 3 × 4.5 inch, four layer printed circuit board	20.31	°C/W
Θ _{JC}	Thermal Resistance (Junction to Case)		8.35	°C/W

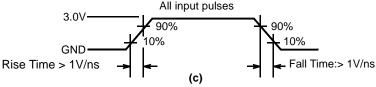
Notes

2. V_{IL} (min) = -2.0V and V_{IH} (max) = V_{CC} + 2V for pulse durations of less than 20 ns. 3. \overline{CE} refers to a combination of \overline{CE}_1 , \overline{CE}_2 , and \overline{CE}_3 . \overline{CE} is LOW when \overline{CE}_1 , \overline{CE}_3 are LOW and \overline{CE}_2 is HIGH. \overline{CE} is HIGH when \overline{CE}_1 is HIGH, or \overline{CE}_2 is LOW, or \overline{CE}_3 is HIGH.









AC Switching Characteristics

Over the Operating Range ^[5]

Parameter	Description	-	10	Unit
Parameter	Description	Min	Max	
Read Cycle				
t _{power} [6]	V _{CC} (Typical) to the First Access	100		μS
t _{RC}	Read Cycle Time	10		ns
t _{AA}	Address to Data Valid		10	ns
t _{OHA}	Data Hold from Address Change	3		ns
t _{ACE}	CE Active LOW to Data Valid [3]		10	ns
t _{DOE}	OE LOW to Data Valid		5	ns
t _{LZOE}	OE LOW to Low Z ^[7]	1		ns
t _{HZOE}	OE HIGH to High Z ^[7]		5	ns
t _{LZCE}	CE Active LOW to Low Z ^[3, 7]	3		ns
t _{HZCE}	CE Deselect HIGH to High Z ^[3, 7]		5	ns
t _{PU}	CE Active LOW to Power Up ^[3, 8]	0		ns
t _{PD}	CE Deselect HIGH to Power Down ^[3, 8]		10	ns

Notes

6. t_{POWER} gives the minimum amount of time that the power supply is at typical V_{CC} values until the first memory access is performed.

7. t_{HZOE}, t_{HZXE}, t_{LZOE}, t_{LZCE}, and t_{LZWE} are specified with a load capacitance of 5 pF as in part (b) of Figure 2. Transition is measured ±200 mV from steady state voltage.

8. These parameters are guaranteed by design and are not tested.

^{4.} Valid SRAM operation does not occur until the power supplies have reached the minimum operating V_{DD} (3.0V). 100 μ s (t_{power}) after reaching the minimum operating V_{DD} , normal SRAM operation can begin including reduction in V_{DD} to the data retention (V_{CCDR} , 2.0V) voltage.

^{5.} Test conditions assume signal transition time of 3 ns or less, timing reference levels of 1.5V, and input pulse levels of 0 to 3.0V. Test conditions for the read cycle use output loading as shown in part a) of Figure 2, unless specified otherwise.



AC Switching Characteristics (continued)

Over the Operating Range ^[5]

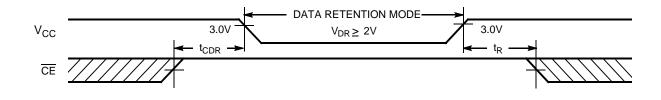
Parameter	Description		Unit	
	Description	Min	Max	Unit
Write Cycle ^{[9, 10}]			
t _{WC}	Write Cycle Time	10		ns
t _{SCE}	CE active LOW to Write End ^[3]	7		ns
t _{AW}	Address Setup to Write End	7		ns
t _{HA}	Address Hold from Write End	0		ns
t _{SA}	Address Setup to Write Start	0		ns
t _{PWE}	WE Pulse Width	7		ns
t _{SD}	Data Setup to Write End	5.5		ns
t _{HD}	Data Hold from Write End	0		ns
t _{LZWE}	WE HIGH to Low Z ^[7]	3		ns
t _{HZWE}	WE LOW to High Z ^[7]		5	ns

Data Retention Characteristics

Over the Operating Range

Parameter	Description	Conditions ^[3]	Min	Тур	Max	Unit
V _{DR}	V _{CC} for Data Retention		2			V
I _{CCDR}	Data Retention Current	$V_{CC} = 2V, \overline{CE} \ge V_{CC} - 0.2V,$ $V_{IN} \ge V_{CC} - 0.2V \text{ or } V_{IN} \le 0.2V$			25	mA
t _{CDR} ^[11]	Chip Deselect to Data Retention Time		0			ns
t _R ^[12]	Operation Recovery Time		t _{RC}			ns

Data Retention Waveform

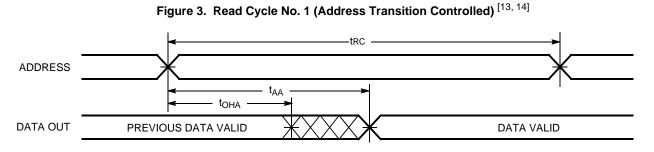


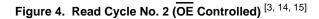
Notes

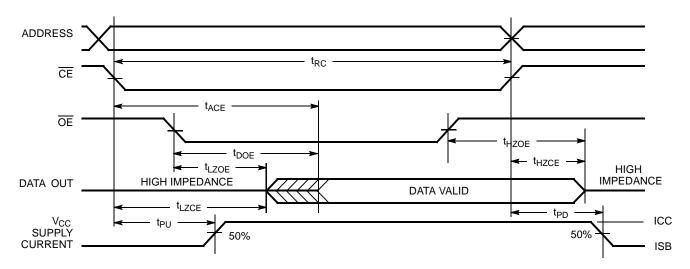
- 9. The internal write time of the memory is defined by the overlap of CE₁ and CE₂ and CE₃ LOW and WE LOW. Chip enables must be active and WE must be LOW to initiate a write. The transition of any of these signals terminate the write. The input data setup and hold timing is referenced to the leading edge of the signal that terminates the write.
- 10. The minimum write cycle time for Write Cycle No. 3 ($\overline{\text{WE}}$ controlled, $\overline{\text{OE}}$ LOW) is the sum of t_{HZWE} and t_{SD}.
- 11. Tested initially and after any design or process changes that may affect these parameters.
- 12. Full device operation requires linear V_{CC} ramp from V_{DR} to V_{CC(min)} \geq 50 µs or stable at V_{CC(min)} \geq 50 µs.

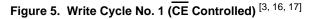


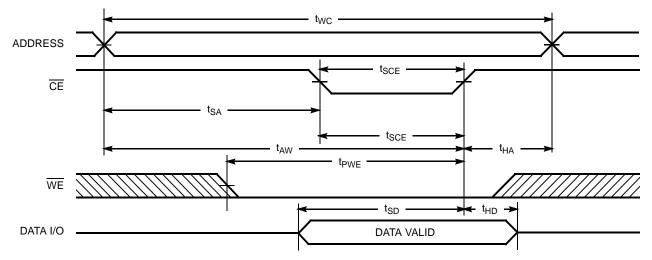
Switching Waveforms











Notes

- 13. Device is continuously selected. \overline{OE} , $\overline{CE} = V_{IL}$.
- 14. WE is HIGH for read cycle.
- 15. Address valid before or similar to $\overline{\text{CE}}$ transition LOW.
- 16. Data I/O is high impedance if $\overline{OE} = V_{IH}$.

17. If TE goes HIGH simultaneously with WE going HIGH, the output remains in a high impedance state.

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Switching Waveforms (continued)

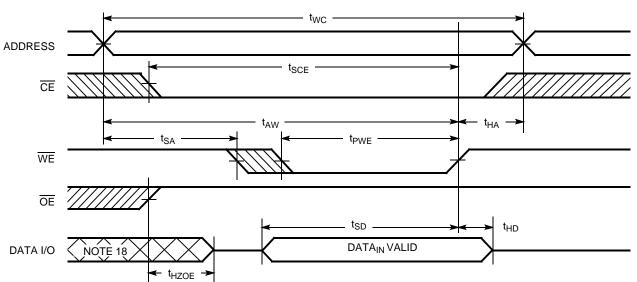
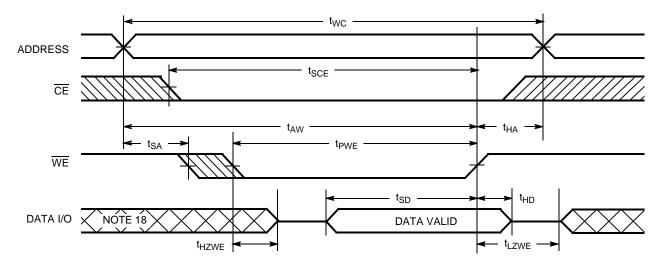


Figure 6. Write Cycle No. 2 ($\overline{\text{WE}}$ Controlled, $\overline{\text{OE}}$ HIGH During Write) ^[3, 16, 17]





Truth Table

CE ₁	CE ₂	CE ₃	OE	WE	1/0 ₀ -1/0 ₂₃	Mode	Power
Н	Х	Х	Х	Х	High Z	Power Down	Standby (I _{SB})
Х	L	Х	Х	Х	High Z	Power Down	Standby (I _{SB})
Х	Х	Н	Х	Х	High Z	Power Down	Standby (I _{SB})
L	Н	L	L	Н	Full Data Out	Read	Active (I _{CC})
L	Н	L	Х	L	Full Data In	Write	Active (I _{CC})
L	Н	L	Н	Н	High Z	Selected, Outputs Disabled	Active (I _{CC})

Note

18. During this period, the I/Os are in the output state and input signals are not applied.

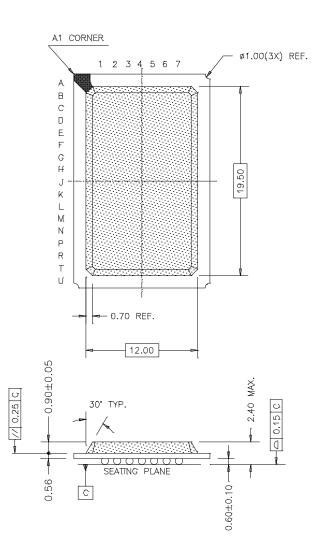


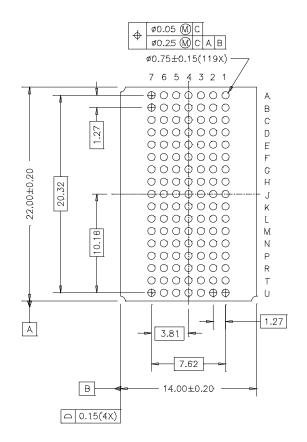
Ordering Information

_	peed (ns)	Ordering Code	Package Name	Package Type	Operating Range
	10	CY7C1024DV33-10BGXI 51-85115		119-Ball Plastic Ball Grid Array (14 x 22 x 2.4 mm) (Pb-Free)	Industrial

Package Diagram

Figure 8. 119-Ball PBGA (14 x 22 x 2.4 mm)





51-85115-*B



Document History Page

Document Title: CY7C1024DV33, 3-Mbit (128K X 24) Static RAM Document Number: 001-08353							
Rev.	ECN No.	Orig. of Change	Submission Date	Description of Change			
**	469517	NXR	See ECN	New data sheet			
*A	499604	NXR	See ECN	Added note 1 for NC pins Changed I _{CC} specification from 150 mA to 185 mA Updated Test Condition for I _{CC} in DC Electrical Characteristics table Added note for t _{ACE} , t _{LZCE} , t _{HZCE} , t _{PU} , t _{PD} , t _{SCE} in AC Switching Characteristics Table on page 4			
*В	1462586	VKN/SFV	See ECN	Converted from preliminary to final Updated block diagram Changed I _{CC} specification from 185 mA to 225 mA Updated thermal specs			
*C	2604677	VKN/PYRS	11/12/08	Removed Commercial operating range, Added Industrial operating range Removed 8 ns speed bin, Added 10 ns speed bin			

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